

**Search Notes**

Application/Control No.

10/667,914

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under  
Reexamination

YAMAZAKI, TAKESHI

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	22,29,33 5,19,23 30,35	5/27/2005	SWH
399	350	5/27/2005	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search (see attached)	5/27/2005	SWH